

| | | | | |
|-----------------------------------|--|---------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination BARTELL ET AL. | |
| | | Examiner AJIT G. PATEL | Art Unit 2616 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-5,313,456 | 05-1994 | Sugawara, Eiji | 370/228 |
| * | B | US-2006/0126500 | 06-2006 | Wakai et al. | 370/218 |
| * | C | US-5,434,691 | 07-1995 | Yamane, Kazuo | 398/5 |
| * | D | US-2006/0203719 | 09-2006 | Kim et al. | 370/227 |
| * | E | US-5,175,639 | 12-1992 | Takasaki, Yoshitaka | 398/67 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.